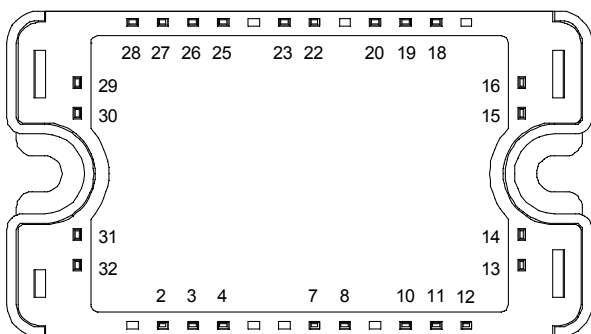
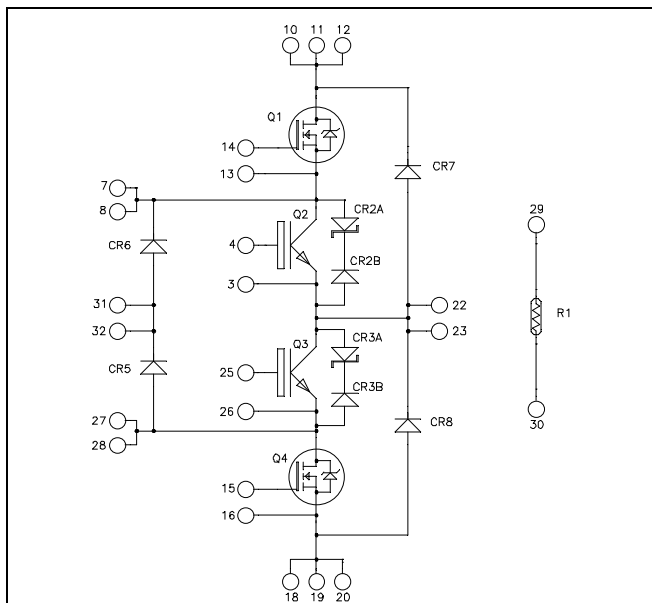


**Three level inverter**  
**CoolMOS & Trench + Field Stop IGBT3**  
**Power Module**

**Trench & Field Stop IGBT3 Q2, Q3:**  
 $V_{CES} = 600V$  ;  $I_C = 30A$  @  $T_c = 80^\circ C$

**CoolMOST<sup>TM</sup> Q1, Q4:**  
 $V_{DSS} = 600V$  ;  $I_D = 17A$  @  $T_c = 80^\circ C$



All multiple inputs and outputs must be shorted together  
Example: 10/11/12 ; 7/8 ...

## Application

- Solar converter
- Uninterruptible Power Supplies

## Features

- **Q2, Q3 Trench + Field Stop IGBT3 Technology**
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- **Q1, Q4 CoolMOST<sup>TM</sup>**
  - Ultra low  $R_{DSon}$
  - Low Miller capacitance
  - Ultra low gate charge
  - Avalanche energy rated
  - Very rugged
- Kelvin emitter for easy drive
- Very low stray inductance
- High level of integration
- Internal thermistor for temperature monitoring

## Benefits

- Stable temperature behavior
- Very rugged
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of  $V_{CESat}$
- Low profile
- RoHS Compliant

**All ratings @  $T_j = 25^\circ C$  unless otherwise specified**

**CAUTION:** These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed.  
See application note APT0502 on [www.microsemi.com](http://www.microsemi.com)

**Q1 & Q4 Absolute maximum ratings** (per CoolMOS™)

Symbol	Parameter	Max ratings	Unit
V <sub>DSS</sub>	Drain - Source Breakdown Voltage	600	V
I <sub>D</sub>	Continuous Drain Current	T <sub>c</sub> = 25°C	22
		T <sub>c</sub> = 80°C	17
I <sub>DM</sub>	Pulsed Drain current	75	A
V <sub>GS</sub>	Gate - Source Voltage	±20	V
R <sub>DS(on)</sub>	Drain - Source ON Resistance	99	mΩ
P <sub>D</sub>	Maximum Power Dissipation	T <sub>c</sub> = 25°C	110
I <sub>AR</sub>	Avalanche current (repetitive and non repetitive)	11	A
E <sub>AR</sub>	Repetitive Avalanche Energy	1.2	mJ
E <sub>AS</sub>	Single Pulse Avalanche Energy	800	

**Q1 & Q4 Electrical Characteristics** (per CoolMOS™)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0V V <sub>DS</sub> = 600V	T <sub>j</sub> = 25°C		50	μA
			T <sub>j</sub> = 125°C	100		
R <sub>DS(on)</sub>	Drain – Source on Resistance	V <sub>GS</sub> = 10V, I <sub>D</sub> = 18A			99	mΩ
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub> = 1.2 mA	2.5	3	3.5	V
I <sub>GSS</sub>	Gate – Source Leakage Current	V <sub>GS</sub> = ±20 V, V <sub>DS</sub> = 0V			100	nA

**Q1 & Q4 Dynamic Characteristics** (per CoolMOS™)

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> = 0V ; V <sub>DS</sub> = 100V f = 1MHz		2800		pF
C <sub>oss</sub>	Output Capacitance			130		
Q <sub>g</sub>	Total gate Charge	V <sub>GS</sub> = 10V V <sub>Bus</sub> = 400V I <sub>D</sub> = 18A		14		nC
Q <sub>gs</sub>	Gate – Source Charge			20		
Q <sub>gd</sub>	Gate – Drain Charge			60		
T <sub>d(on)</sub>	Turn-on Delay Time	V <sub>GS</sub> = 10V V <sub>Bus</sub> = 400V I <sub>D</sub> = 18A R <sub>G</sub> = 3.3Ω		10		ns
T <sub>r</sub>	Rise Time			5		
T <sub>d(off)</sub>	Turn-off Delay Time			60		
T <sub>f</sub>	Fall Time			5		
R <sub>thJC</sub>	Junction to Case Thermal Resistance				1.15	°C/W

**Q2 & Q3 Absolute maximum ratings** (per IGBT)

Symbol	Parameter	Max ratings	Unit
V <sub>CES</sub>	Collector - Emitter Breakdown Voltage	600	V
I <sub>C</sub>	Continuous Collector Current	T <sub>C</sub> = 25°C	50
		T <sub>C</sub> = 80°C	30
I <sub>CM</sub>	Pulsed Collector Current	T <sub>C</sub> = 25°C	60
V <sub>GE</sub>	Gate – Emitter Voltage	±20	V
P <sub>D</sub>	Maximum Power Dissipation	T <sub>C</sub> = 25°C	90
RBSOA	Reverse Bias Safe Operating Area	T <sub>J</sub> = 150°C	60A @ 550V

**Q2 & Q3 Electrical Characteristics (per IGBT)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$I_{CES}$	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 600V$			250	$\mu A$
$V_{CE(sat)}$	Collector Emitter Saturation Voltage	$V_{GE} = 15V$ $I_C = 30A$		1.5 1.7	1.9	V
		$T_j = 25^\circ C$ $T_j = 150^\circ C$				
$V_{GE(th)}$	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 400\mu A$	5.0	5.8	6.5	V
$I_{GES}$	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$			300	nA

**Q2 & Q3 Dynamic Characteristics (per IGBT)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$C_{ies}$	Input Capacitance	$V_{GE} = 0V$		1600		pF
$C_{oes}$	Output Capacitance	$V_{CE} = 25V$		110		
$C_{res}$	Reverse Transfer Capacitance	$f = 1MHz$		50		
$Q_G$	Gate charge	$V_{GE} = \pm 15V, I_C = 30A$ $V_{CE} = 300V$		0.3		$\mu C$
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $25^\circ C$ ) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 30A$ $R_G = 10\Omega$		110		ns
$T_r$	Rise Time			45		
$T_{d(off)}$	Turn-off Delay Time			200		
$T_f$	Fall Time			40		
$T_{d(on)}$	Turn-on Delay Time	Inductive Switching ( $150^\circ C$ ) $V_{GE} = \pm 15V$ $V_{Bus} = 300V$ $I_C = 30A$ $R_G = 10\Omega$		120		ns
$T_r$	Rise Time			50		
$T_{d(off)}$	Turn-off Delay Time			250		
$T_f$	Fall Time			60		
$E_{on}$	Turn-on Switching Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 300V$		0.16 0.3		mJ
		$T_j = 25^\circ C$ $T_j = 150^\circ C$				
$E_{off}$	Turn-off Switching Energy	$I_C = 30A$ $R_G = 10\Omega$		0.7 1.05		mJ
		$T_j = 25^\circ C$ $T_j = 150^\circ C$				
$I_{sc}$	Short Circuit data	$V_{GE} \leq 15V; V_{Bus} = 360V$ $t_p \leq 6\mu s; T_j = 150^\circ C$		150		A
$R_{thJC}$	Junction to Case Thermal Resistance				1.6	$^\circ C/W$

**CR2 & CR3 diode ratings and characteristics (per device)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
$V_F$	Diode + tranzorb Forward Voltage	$I_F = 10A$		10		V
$R_{thJC}$	Junction to Case Thermal Resistance				8	$^\circ C/W$

**CR5 & CR6 diode ratings and characteristics (per diode)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage		600			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =600V			25	μA
I <sub>F</sub>	DC Forward Current	T <sub>C</sub> = 80°C		30		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A		1.8	2.2	V
		I <sub>F</sub> = 60A		2.2		
		I <sub>F</sub> = 30A T <sub>j</sub> = 125°C		1.5		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30A V <sub>R</sub> = 400V di/dt = 200A/μs	T <sub>j</sub> = 25°C	25		ns
			T <sub>j</sub> = 125°C	160		
Q <sub>rr</sub>	Reverse Recovery Charge		T <sub>j</sub> = 25°C	35		nC
			T <sub>j</sub> = 125°C	480		
E <sub>rr</sub>	Reverse Recovery Energy	I <sub>F</sub> = 30A V <sub>R</sub> = 400V di/dt = 1000A/μs	T <sub>j</sub> = 125°C	0.6		mJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance				1.2	°C/W

**CR7 & CR8 diode ratings and characteristics (per diode)**

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage		1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V			100	μA
I <sub>F</sub>	DC Forward Current	T <sub>C</sub> = 80°C		30		A
V <sub>F</sub>	Diode Forward Voltage	I <sub>F</sub> = 30A		2.6	3.1	V
		I <sub>F</sub> = 60A		3.2		
		I <sub>F</sub> = 30A T <sub>j</sub> = 125°C		1.8		
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> = 30A V <sub>R</sub> = 800V di/dt = 200A/μs	T <sub>j</sub> = 25°C	300		ns
			T <sub>j</sub> = 125°C	380		
Q <sub>rr</sub>	Reverse Recovery Charge		T <sub>j</sub> = 25°C	360		nC
			T <sub>j</sub> = 125°C	1700		
E <sub>rr</sub>	Reverse Recovery Energy	I <sub>F</sub> = 30A V <sub>R</sub> = 800V di/dt = 1000A/μs	T <sub>j</sub> = 125°C	1.6		mJ
R <sub>thJC</sub>	Junction to Case Thermal Resistance				1.2	°C/W

**Temperature sensor NTC** (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Typ	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
ΔR <sub>25</sub> /R <sub>25</sub>			5		%
B <sub>25/85</sub>	T <sub>25</sub> = 298.15 K		3952		K
ΔB/B	T <sub>C</sub> =100°C		4		%

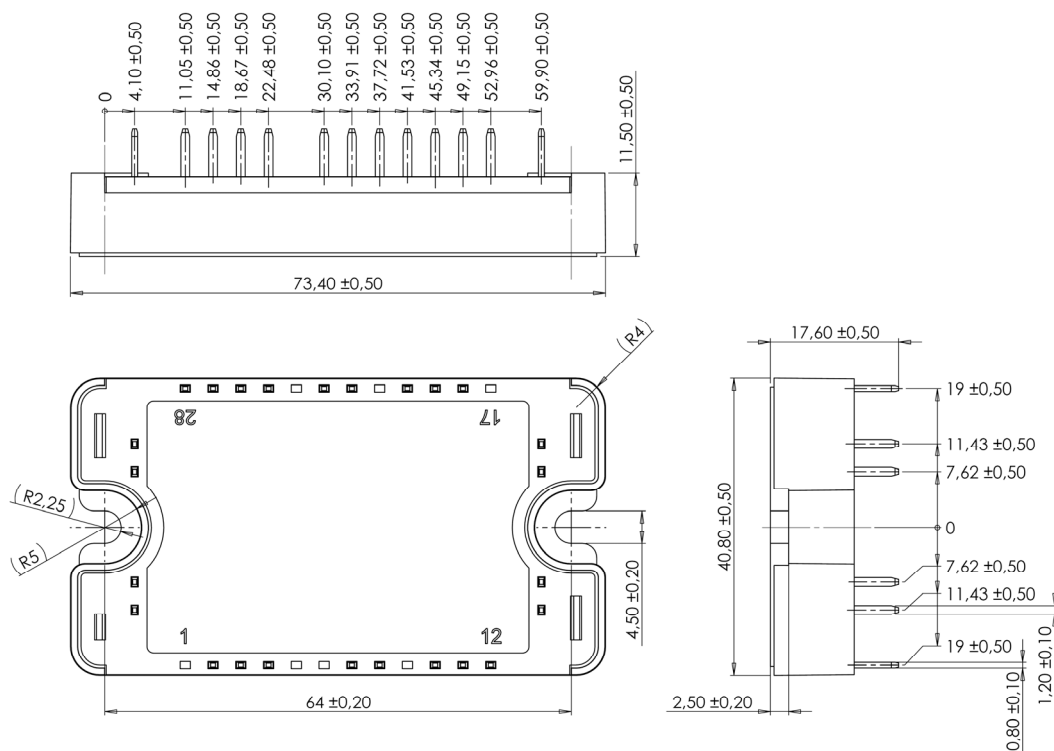
$$R_T = \frac{R_{25}}{\exp \left[ B_{25/85} \left( \frac{1}{T_{25}} - \frac{1}{T} \right) \right]}$$

T: Thermistor temperature  
R<sub>T</sub>: Thermistor value at T

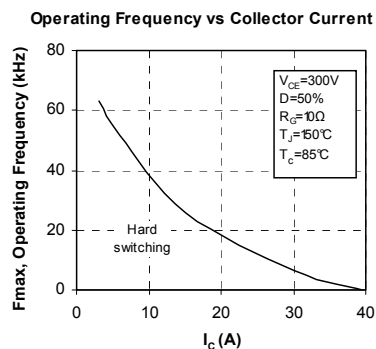
**Thermal and package characteristics**

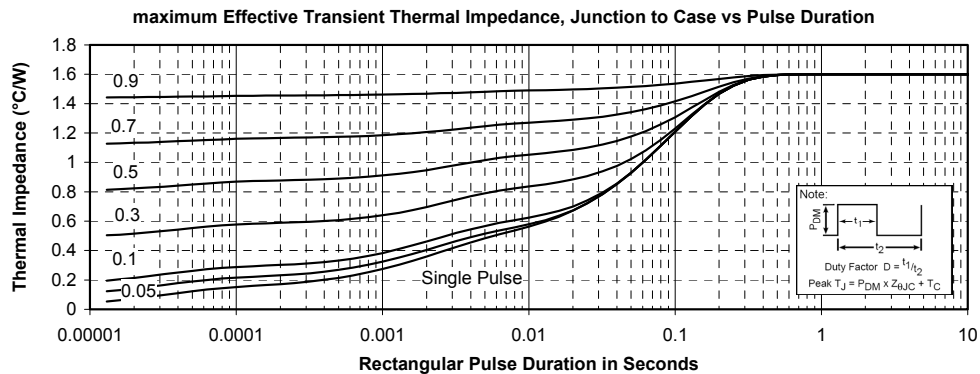
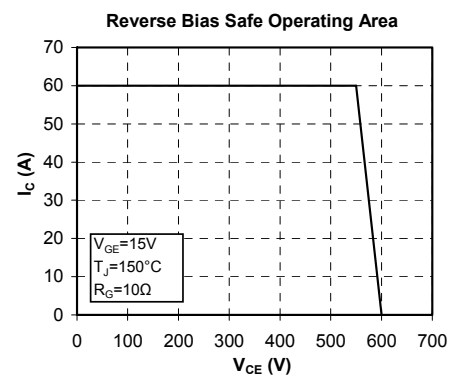
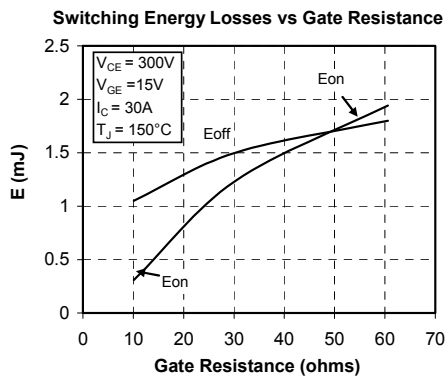
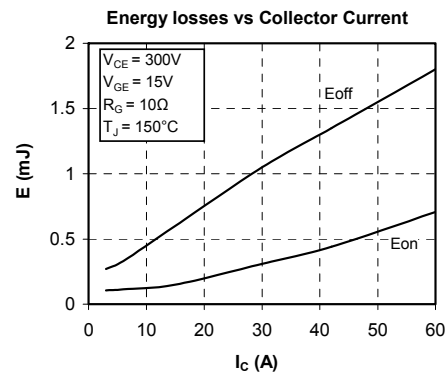
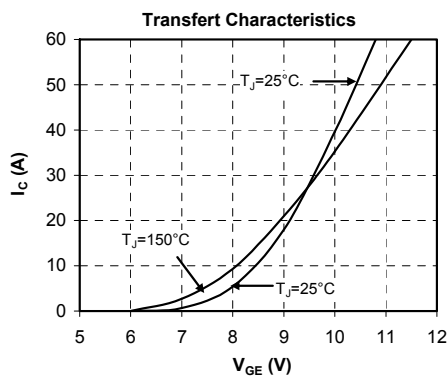
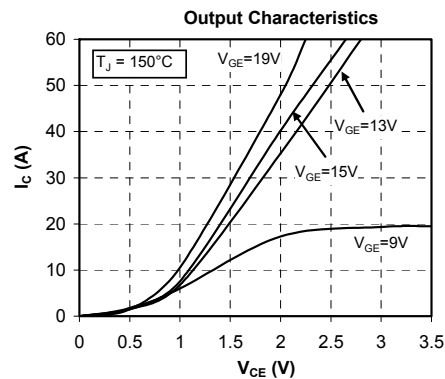
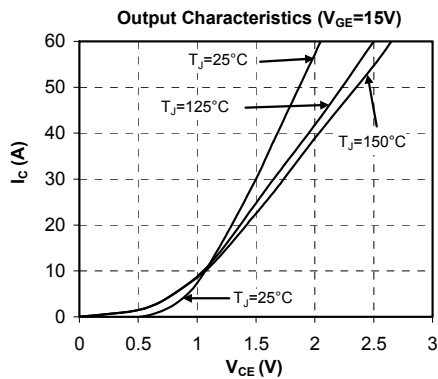
Symbol	Characteristic	Min	Typ	Max	Unit
V <sub>ISOL</sub>	RMS Isolation Voltage, any terminal to case t=1 min, 50/60Hz	4000			V
T <sub>J</sub>	Operating junction temperature range	-40		175*	°C
T <sub>STG</sub>	Storage Temperature Range	-40		125	
T <sub>C</sub>	Operating Case Temperature	-40		100	
Torque	Mounting torque	To heatsink		M4	
Wt	Package Weight			110	g

\* T<sub>jmax</sub> = 150°C for Q1 & Q4

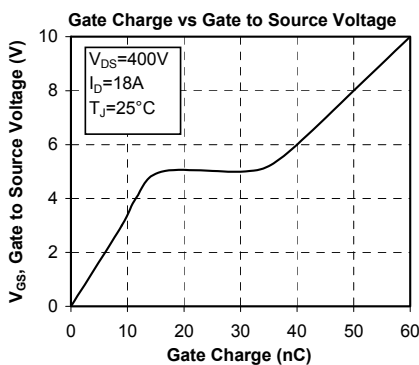
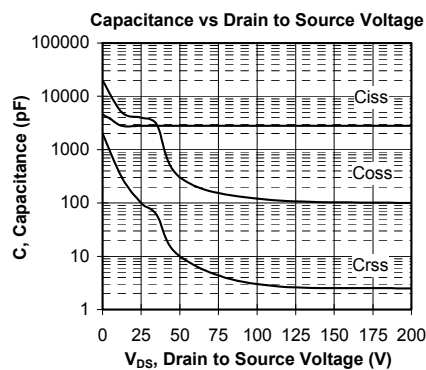
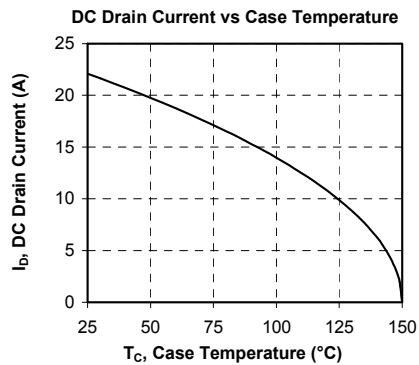
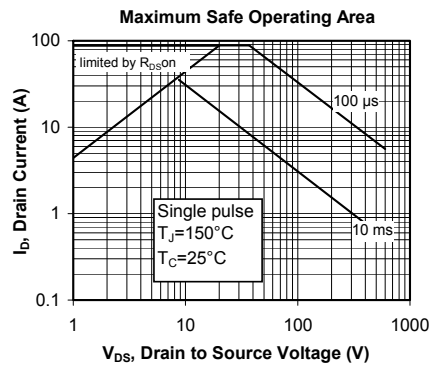
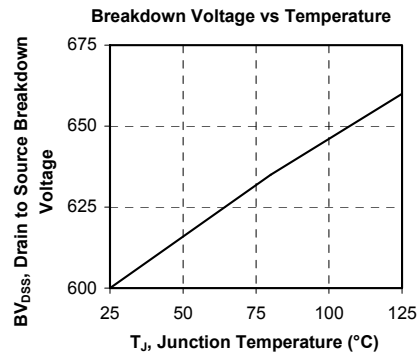
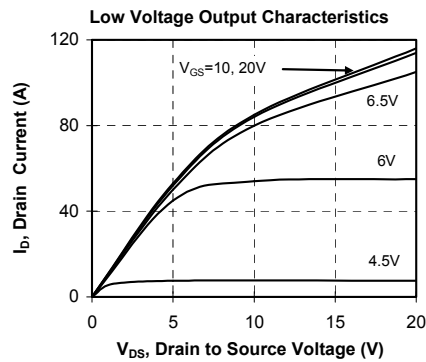
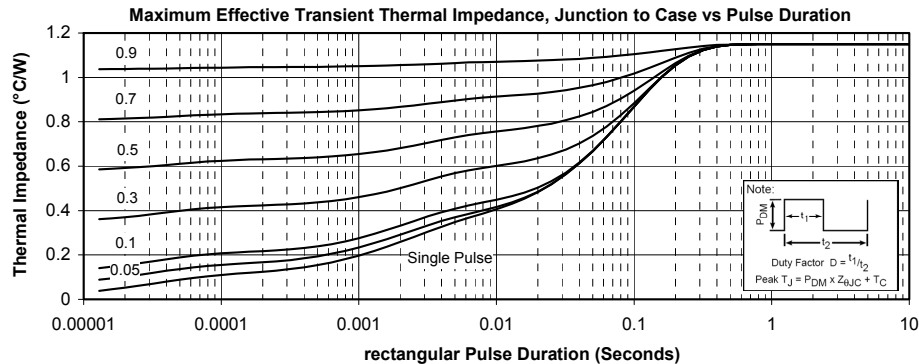
**SP3 Package outline (dimensions in mm)**


See application note 1901 - Mounting Instructions for SP3 Power Modules on [www.microsemi.com](http://www.microsemi.com)

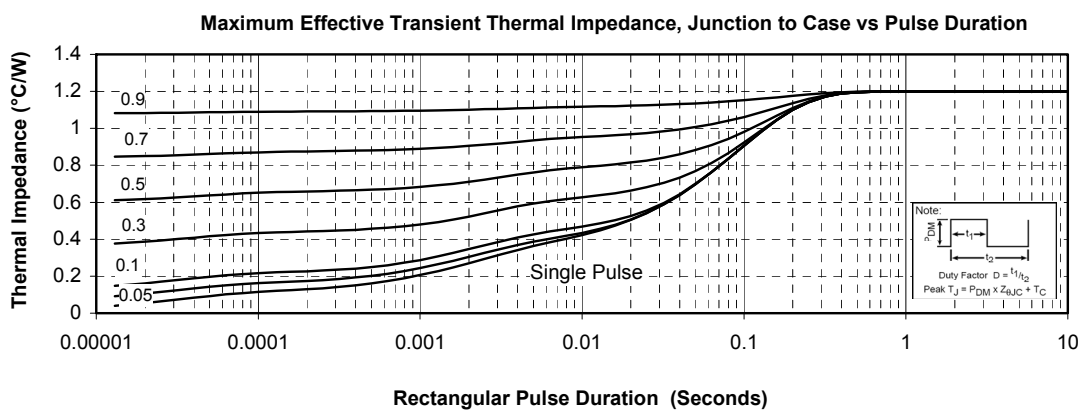
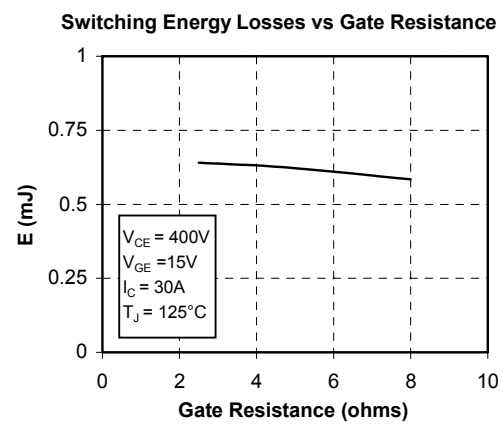
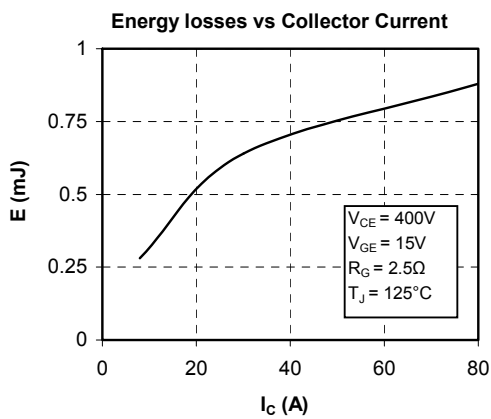
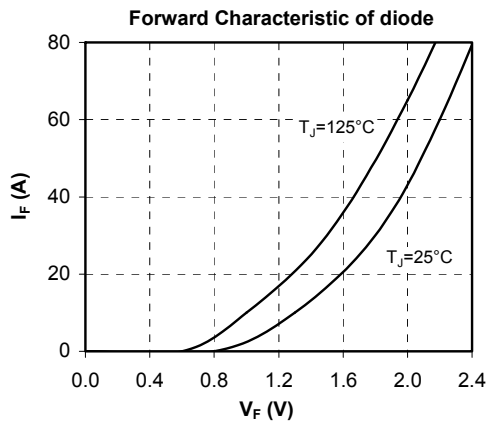
**Q2 & Q3 Typical performance curve**




## Q1 & Q4 Typical performance curve

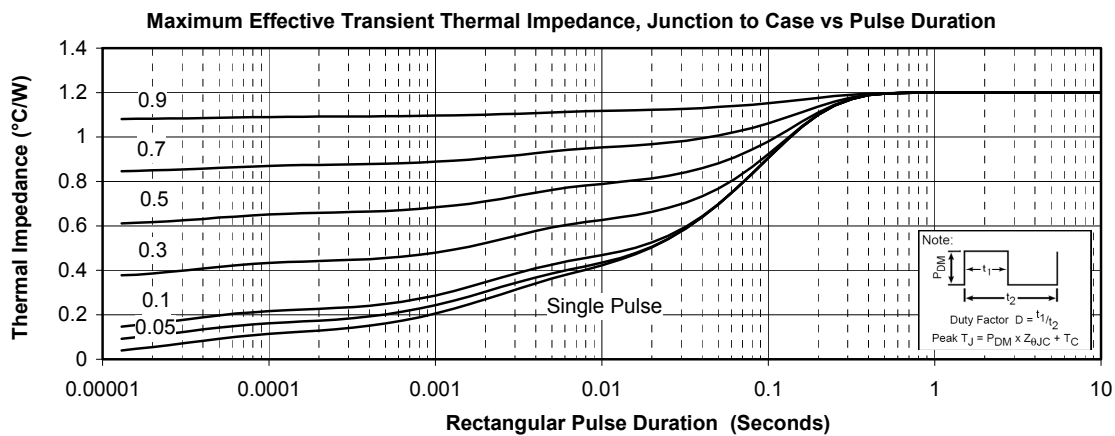
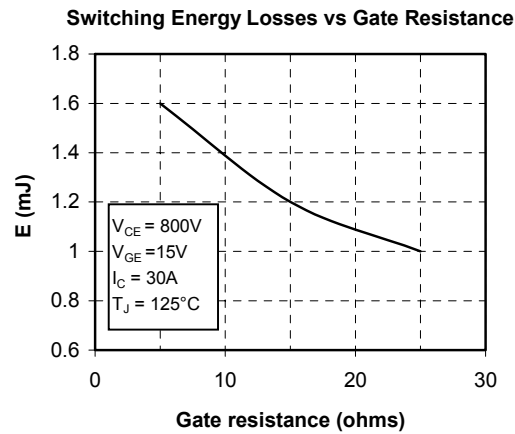
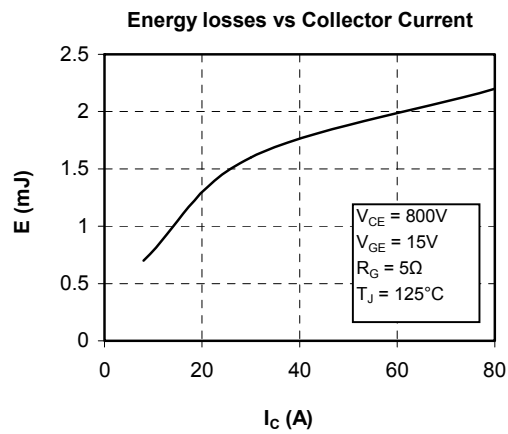
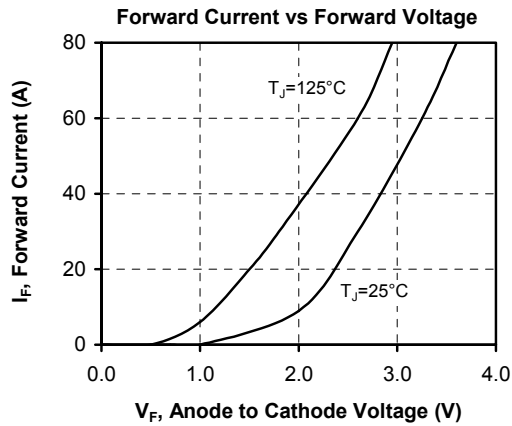


**CR5 & CR6 Typical performance curve**





## CR7 & CR8 Typical performance curve



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